Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/674,815	AOMATSU, AKIRA
Examiner	Art Unit
Brian S. Kwon	1614

SEARCHED				
Class	Subclass	Date	Examiner	
514	561	6/20/2006	BK),	
424	451		#/	
Updated		V	V	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NO' (INCLUDING SEARCH)
	DATE	EXMR
Updated (STN, EAST, NPL)	6/20/2006	вк
Updated (Continuity Data, Inventor Name Search)		